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REVISION HISTORY

5/16—Rev. E to Rev. F

Changes to Figure 1	1
Reformatted and Changes to Pin Configuration and Function Descriptions Section	7
Added Figure 6, Renumbered Sequentially	8

2/16—Rev. D to Rev. E

Changes to Figure 1 and General Description Section	1
Changes to Table 2	3
Changes to Table 3 and Table 4	4
Changes to Table 5 and Table 6	5
Changes to Figure 3, Figure 4, and Table 8 Caption	7
Added Table 9; Renumbered Sequentially	7
Changes to Figure 5 and Table 10 Caption	8
Changes to Figure 6 Caption	9
Changes to Figure 14 Caption and Figure 15 Caption	10
Changes to Figure 21 Caption and Figure 23 Caption	11
Changed Circuit Description Section to Theory of Operation Section	13
Changes to Figure 28	13
Changes to the Three-State Bus Connection Section and the Shutdown Mode Section	14
Updated Outline Dimensions	15
Changes to Ordering Guide	16

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1/12—Rev. C to Rev. D

Change to Features Section	1
Changes to Ordering Guide	15
Added Automotive Products Section	15

1/11—Rev. B to Rev. C

Change to Table 8, Pin 3 Description	7
Changes to Figure 29	12
Changes to Ordering Guide	15

7/09—Rev. A to Rev. B

Added MSOP Package	Universal
Changes to Table 2	3
Changes to Table 7	6
Inserted Figure 4; Renumbered Sequentially	7
Moved Typical Performance Characteristics Section	8
Changes to Figure 24 and Figure 27	11
Changes to Figure 29	12
Change to Shutdown Mode Section	13
Updated Outline Dimensions	14
Changes to Ordering Guide	15

4/09—Rev. 0 to Rev. A

Changes to Ordering Guide	15
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10/04—Revision 0: Initial Version

SPECIFICATIONS

$V_{CC} = 5\text{ V} \pm 5\%$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.

Table 2.

Parameter		Min	Typ	Max	Unit	Test Conditions/Comments
DRIVER						
Differential Output Voltage	V_{OD}			V_{CC}	V	$R = \infty$, see Figure 19 ¹
		2.0		5	V	$R = 50\ \Omega$ (RS-422), see Figure 19
		1.5		5	V	$R = 27\ \Omega$ (RS-485), see Figure 19
Differential Output Voltage over Common-Mode Range	$ V_{OD3} $	1.5		5	V	$V_{TST} = -7\text{ V}$ to $+12\text{ V}$, see Figure 20
$\Delta V_{OD} $ for Complementary Output States				0.2	V	$R = 27\ \Omega$ or $50\ \Omega$, see Figure 19
Common-Mode Output Voltage	V_{OC}			3	V	$R = 27\ \Omega$ or $50\ \Omega$, see Figure 19
$\Delta V_{OC} $ for Complementary Output States				0.2	V	$R = 27\ \Omega$ or $50\ \Omega$, see Figure 19
Output Short-Circuit Current						$-7\text{ V} < V_{OUT} < +12\text{ V}$
$V_{OUT} = \text{High}$		-200		+200	mA	
$V_{OUT} = \text{Low}$		-200		+200	mA	
DRIVER INPUT LOGIC						
CMOS Input Logic Threshold						
Low				0.8	V	
High		2.0			V	
CMOS Logic Input Current (DI)				± 1	μA	
DE Input Resistance to GND			220		k Ω	
RECEIVER						
Differential Input Threshold Voltage	V_{TH}	-200	-125	-30	mV	$-7\text{ V} < V_{OC} < +12\text{ V}$
Input Hysteresis			20		mV	$-7\text{ V} < V_{OC} < +12\text{ V}$
Input Resistance (A, B)		96	150		k Ω	$-7\text{ V} < V_{OC} < +12\text{ V}$
Input Current (A, B)				0.125	mA	$V_{IN} = 12\text{ V}$
				-0.1	mA	$V_{IN} = -7\text{ V}$
CMOS Logic Input Current ($\overline{RE}$)				± 1	μA	
CMOS Output Voltage						
Low				0.4	V	$I_{OUT} = 4\text{ mA}$
High		4.0			V	$I_{OUT} = -4\text{ mA}$
Output Short-Circuit Current		7		85	mA	$V_{OUT} = \text{GND}$ or V_{CC}
Three-State Output Leakage Current				± 2	μA	$0.4\text{ V} \leq V_{OUT} \leq 2.4\text{ V}$
POWER SUPPLY CURRENT						
115 kbps Options (ADM4850/ADM4854)				5	μA	$DE = 0\text{ V}$, $\overline{RE} = V_{CC}$ (shutdown)
			36	60	μA	$DE = 0\text{ V}$, $\overline{RE} = 0\text{ V}$
			100	160	μA	$DE = V_{CC}$
500 kbps Options (ADM4855)				5	μA	$DE = 0\text{ V}$, $\overline{RE} = V_{CC}$ (shutdown)
			80	120	μA	$DE = 0\text{ V}$, $\overline{RE} = 0\text{ V}$
			120	200	μA	$DE = V_{CC}$
2.5 Mbps Options (ADM4852/ADM4856)				5	μA	$DE = 0\text{ V}$, $\overline{RE} = V_{CC}$ (shutdown)
			250	400	μA	$DE = 0\text{ V}$, $\overline{RE} = 0\text{ V}$
			320	500	μA	$DE = V_{CC}$
10 Mbps Options (ADM4853/ADM4857)				5	μA	$DE = 0\text{ V}$, $\overline{RE} = V_{CC}$ (shutdown)
			250	400	μA	$DE = 0\text{ V}$, $\overline{RE} = 0\text{ V}$
			320	500	μA	$DE = V_{CC}$

¹ Guaranteed by design.

ADM4850/ADM4854 TIMING SPECIFICATIONS

$V_{CC} = 5\text{ V} \pm 5\%$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.

Table 3.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
DRIVER						
Maximum Data Rate		115			kbps	
Propagation Delay	t_{PLH}, t_{PHL}	600		2500	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Skew	t_{SKEW}			70	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Rise/Fall Times	t_R, t_F	600		2400	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Enable Time	t_{ZH}, t_{ZL}			2000	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4850 only)
Disable Time	t_{LZ}, t_{HZ}			2000	ns	$R_L = 500\ \Omega$, $C_L = 15\text{ pF}$, see Figure 22 and Figure 27 (ADM4850 only)
Enable Time from Shutdown			4000		ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 (ADM4850 only)
RECEIVER						
Propagation Delay	t_{PLH}, t_{PHL}	400		1000	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Differential Skew	t_{SKEW}			255	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Enable Time	t_{ZH}, t_{ZL}		5	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4850 only)
Disable Time	t_{LZ}, t_{HZ}		20	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4850 only)
Enable Time from Shutdown			4000		ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 (ADM4850 only)
Time to Shutdown		50	330	3000	ns	ADM4850 only ¹

¹ The half-duplex device is put into shutdown mode by driving $\overline{RE}$ high and DE low. If these inputs are in this state for less than 50 ns, the device is guaranteed not to enter shutdown mode. If the enable inputs are in this state for at least 3000 ns, the device is guaranteed to enter shutdown mode.

ADM4851/ADM4855 TIMING SPECIFICATIONS

$V_{CC} = 5\text{ V} \pm 5\%$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.

Table 4.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
DRIVER						
Maximum Data Rate		500			kbps	
Propagation Delay	t_{PLH}, t_{PHL}	250		600	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Skew	t_{SKEW}			40	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Rise/Fall Times	t_R, t_F	200		600	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Enable Time	t_{ZH}, t_{ZL}			1000	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4851 only)
Disable Time	t_{LZ}, t_{HZ}			1000	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4851 only)
Enable Time from Shutdown			4000		ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 (ADM4851 only)
RECEIVER						
Propagation Delay	t_{PLH}, t_{PHL}	400		1000	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Differential Skew	t_{SKEW}			250	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Enable Time	t_{ZH}, t_{ZL}		5	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4851 only)
Disable Time	t_{LZ}, t_{HZ}		20	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4851 only)
Enable Time from Shutdown			4000		ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 (ADM4851 only)
Time to Shutdown		50	330	3000	ns	ADM4851 only ¹

¹ The half-duplex device is put into shutdown mode by driving $\overline{RE}$ high and DE low. If these inputs are in this state for less than 50 ns, the device is guaranteed not to enter shutdown mode. If the enable inputs are in this state for at least 3000 ns, the device is guaranteed to enter shutdown mode.

ADM4852/ADM4856 TIMING SPECIFICATIONS

$V_{CC} = 5\text{ V} \pm 5\%$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.

Table 5.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
DRIVER						
Maximum Data Rate		2.5			Mbps	
Propagation Delay	t_{PLH}, t_{PHL}	50		180	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Skew	t_{SKEW}			50	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Rise/Fall Times	t_R, t_F			140	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Enable Time	t_{ZH}, t_{ZL}			180	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4852 only)
Disable Time	t_{LZ}, t_{HZ}			180	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4852 only)
Enable Time from Shutdown			4000		ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 (ADM4852 only)
RECEIVER						
Propagation Delay	t_{PLH}, t_{PHL}	55		190	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Differential Skew	t_{SKEW}			50	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Enable Time	t_{ZH}, t_{ZL}		5	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4852 only)
Disable Time	t_{LZ}, t_{HZ}		20	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4852 only)
Enable Time from Shutdown			4000		ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 (ADM4852 only)
Time to Shutdown		50	330	3000	ns	ADM4852 only ¹

¹ The half-duplex device is put into shutdown mode by driving $\overline{RE}$ high and DE low. If these inputs are in this state for less than 50 ns, the device is guaranteed not to enter shutdown mode. If the enable inputs are in this state for at least 3000 ns, the device is guaranteed to enter shutdown mode.

ADM4853/ADM4857 TIMING SPECIFICATIONS

$V_{CC} = 5\text{ V} \pm 5\%$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.

Table 6.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
DRIVER						
Maximum Data Rate		10			Mbps	
Propagation Delay	t_{PLH}, t_{PHL}	0		30	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Skew	t_{SKEW}			10	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Rise/Fall Times	t_R, t_F			30	ns	$R_{LDIFF} = 54\ \Omega$, $C_{L1} = C_{L2} = 100\text{ pF}$, see Figure 21 and Figure 25
Enable Time	t_{ZH}, t_{ZL}			35	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4853 only)
Disable Time	t_{LZ}, t_{HZ}			35	ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 and Figure 27 (ADM4853 only)
Enable Time from Shutdown			4000		ns	$R_L = 500\ \Omega$, $C_L = 100\text{ pF}$, see Figure 22 (ADM4853 only)
RECEIVER						
Propagation Delay	t_{PLH}, t_{PHL}	55		190	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Differential Skew	t_{SKEW}			30	ns	$C_L = 15\text{ pF}$, see Figure 23 and Figure 26
Enable Time	t_{ZH}, t_{ZL}		5	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4853 only)
Disable Time	t_{LZ}, t_{HZ}		20	50	ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 and Figure 28 (ADM4853 only)
Enable Time from Shutdown			4000		ns	$R_L = 1\text{ k}\Omega$, $C_L = 15\text{ pF}$, see Figure 24 (ADM4853 only)
Time to Shutdown		50	330	3000	ns	ADM4853 only ¹

¹ The half-duplex device is put into shutdown mode by driving $\overline{RE}$ high and DE low. If these inputs are in this state for less than 50 ns, the device is guaranteed not to enter shutdown mode. If the enable inputs are in this state for at least 3000 ns, the device is guaranteed to enter shutdown mode.

ABSOLUTE MAXIMUM RATINGS

Table 7.

Parameter	Rating
V_{CC} to GND	6 V
Digital Input/Output Voltage (DE, $\overline{RE}$, DI, RO)	−0.3 V to $V_{CC} + 0.3$ V
Driver Output/Receiver Input Voltage	−9 V to +14 V
Operating Temperature Range	−40°C to +85°C
Storage Temperature Range	−65°C to +125°C
θ_{JA} Thermal Impedance	
8-Lead SOIC	110°C/W
8-Lead LFCSP	62°C/W
8-Lead MSOP	133.1°C/W
Lead Temperature	
Soldering (10 sec)	300°C
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

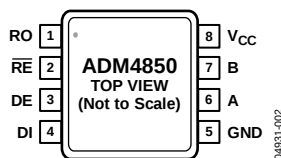


Figure 3. ADM4850, 8-Lead MSOP, Pin Configuration

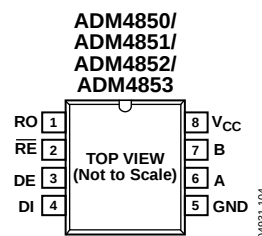
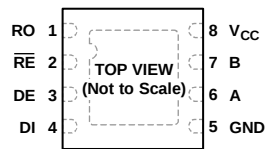


Figure 4. ADM4850/ADM4851/ADM4852/ADM4853, 8-Lead SOIC, Pin Configuration

Table 8. ADM4850/ADM4851/ADM4852/ADM4853, 8-Lead MSOP and 8-Lead SOIC, Pin Function Descriptions

Pin No.	Mnemonic	Description
1	RO	Receiver Output. When RO is enabled and $(A - B) \geq -30 \text{ mV}$, RO is high. When RO is enabled and $(A - B) \leq -200 \text{ mV}$, RO is low.
2	$\overline{\text{RE}}$	Receiver Output Enable. A low level on $\overline{\text{RE}}$ enables the receiver output (RO). A high level on $\overline{\text{RE}}$ places RO into a high impedance state.
3	DE	Driver Output Enable. A high level on DE enables the driver differential outputs (A and B). A low level on DE places the driver differential outputs into a high impedance state.
4	DI	Driver Input. When the driver is enabled, a logic low on DI forces A low and B high, whereas a logic high on DI forces A high and B low.
5	GND	Ground.
6	A	Noninverting Receiver Input A/Noninverting Driver Output A.
7	B	Inverting Receiver Input B/Inverting Driver Output B.
8	V_{CC}	5 V Power Supply.

ADM4850/ADM4852/ADM4853



NOTES

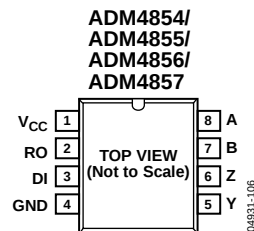
1. THE EXPOSED PADDLE ON THE UNDERSIDE OF THE PACKAGE SHOULD BE SOLDERED TO THE GROUND PLANE TO INCREASE THE RELIABILITY OF THE SOLDER JOINTS AND TO MAXIMIZE THE THERMAL CAPABILITY OF THE PACKAGE.

04931-029

Figure 5. ADM4850/ADM4852/ADM4853, 8-Lead LFCSP, Pin Configuration

Table 9. ADM4850/ADM4852/ADM4853, 8-Lead LFCSP, Pin Function Descriptions

Pin No.	Mnemonic	Description
1	RO	Receiver Output. When RO is enabled and $(A - B) \geq -30$ mV, RO is high. When RO is enabled and $(A - B) \leq -200$ mV, RO is low.
2	$\overline{RE}$	Receiver Output Enable. A low level on $\overline{RE}$ enables the receiver output (RO). A high level on $\overline{RE}$ places RO into a high impedance state.
3	DE	Driver Output Enable. A high level on DE enables the driver differential outputs (A and B). A low level places the driver differential outputs into a high impedance state.
4	DI	Driver Input. When the driver is enabled, a logic low on DI forces A low and B high, whereas a logic high on DI forces A high and B low.
5	GND	Ground.
6	A	Noninverting Receiver Input A/Noninverting Driver Output A.
7	B	Inverting Receiver Input B/Inverting Driver Output B.
8	V_{CC}	5 V Power Supply.
	EPAD	Exposed Pad. The exposed paddle on the underside of the package must be soldered to the ground plane to increase the reliability of the solder joints and to maximize the thermal capability of the package.



04931-106

Figure 6. ADM4854/ADM4855/ADM4856/ADM4857, 8-Lead SOIC, Pin Configuration

Table 10. ADM4854/ADM4855/ADM4856/ADM4857, 8-Lead SOIC, Pin Function Descriptions

Pin No.	Mnemonic	Description
1	V_{CC}	5 V Power Supply.
2	RO	Receiver Output. When RO is enabled and $(A - B) \geq -30$ mV, RO is high. When RO is enabled and $(A - B) \leq -200$ mV, RO is low.
3	DI	Driver Input. When the driver is enabled, a logic low on DI forces Y low and Z high, whereas a logic high on DI forces Y high and Z low.
4	GND	Ground.
5	Y	Noninverting Driver Output.
6	Z	Inverting Driver Output.
7	B	Inverting Receiver Input.
8	A	Noninverting Receiver Input.

TYPICAL PERFORMANCE CHARACTERISTICS

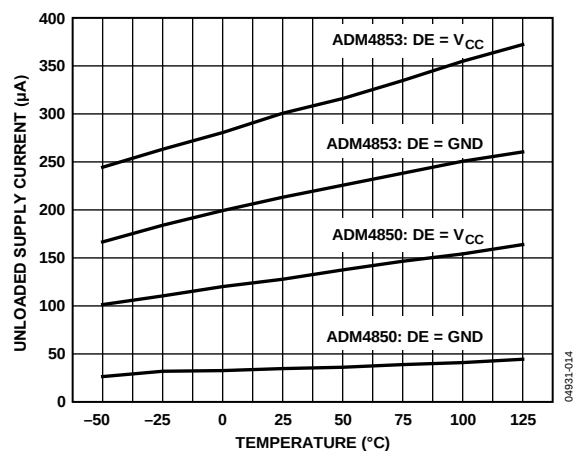


Figure 7. Unloaded Supply Current vs. Temperature (ADM4850/ADM4853)

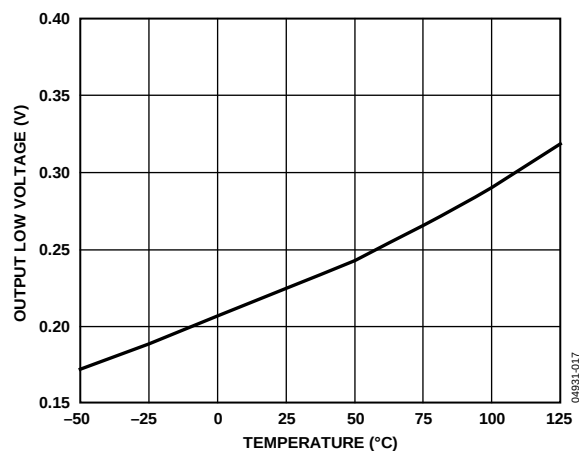


Figure 10. Receiver Output Low Voltage vs. Temperature

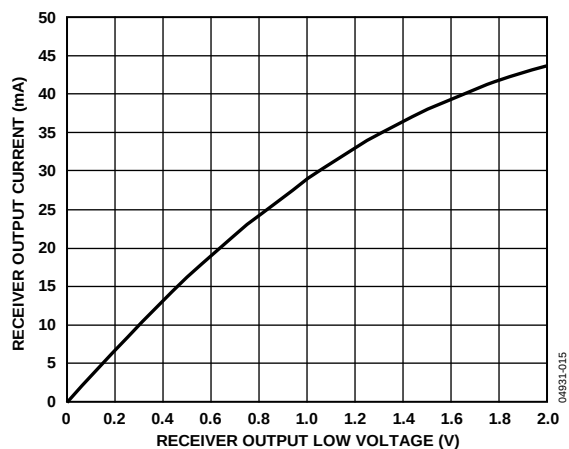


Figure 8. Receiver Output Current vs. Receiver Output Low Voltage

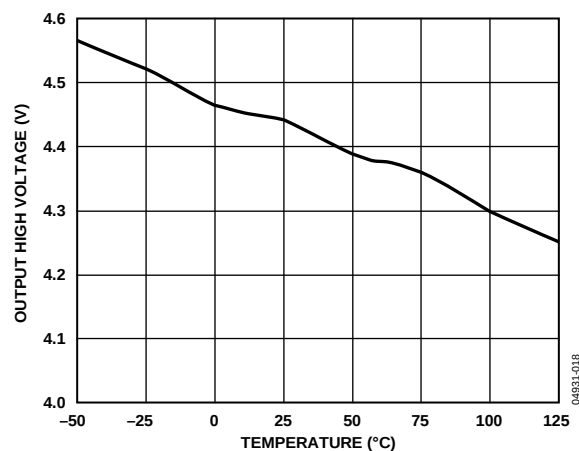


Figure 11. Receiver Output High Voltage vs. Temperature

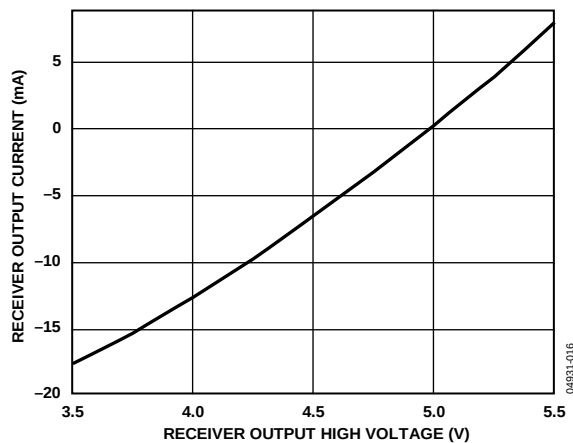


Figure 9. Receiver Output Current vs. Receiver Output High Voltage

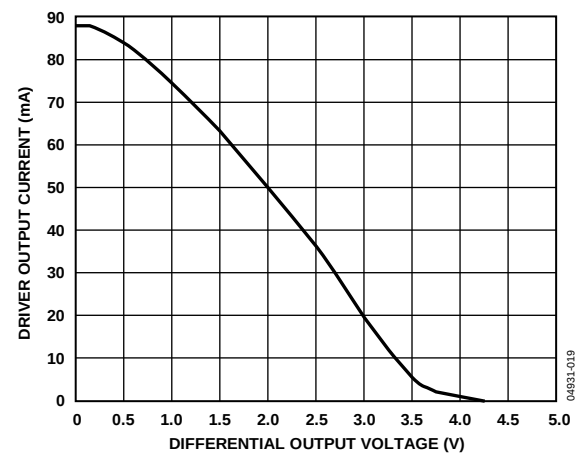


Figure 12. Driver Output Current vs. Differential Output Voltage

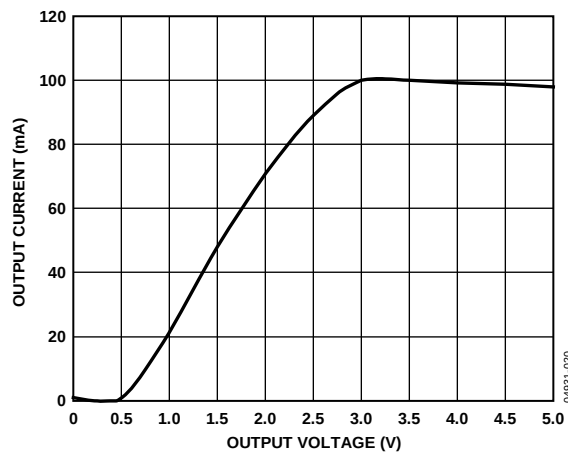


Figure 13. Output Current vs. Driver Output Low Voltage

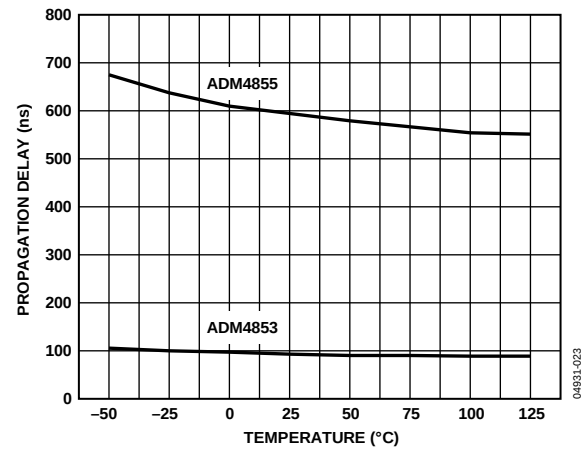


Figure 16. Receiver Propagation Delay vs. Temperature (ADM4853/ADM4855)

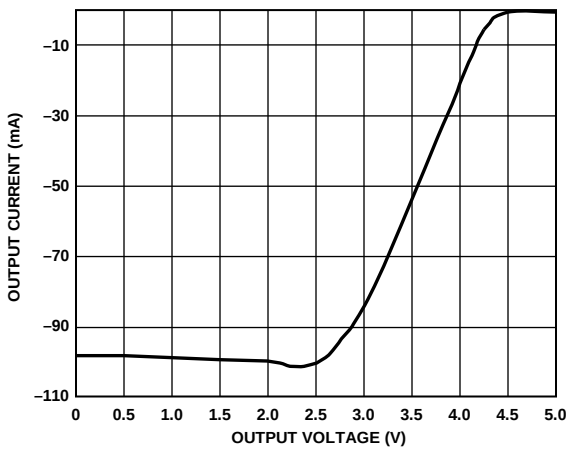


Figure 14. Output Current vs. Driver Output High Voltage

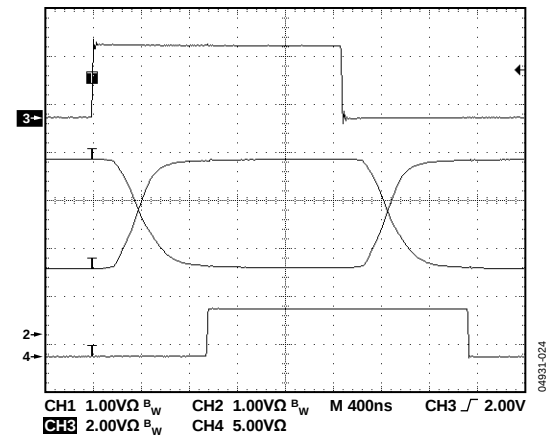


Figure 17. Driver/Receiver Propagation Delay (ADM4855, 500 kbps)

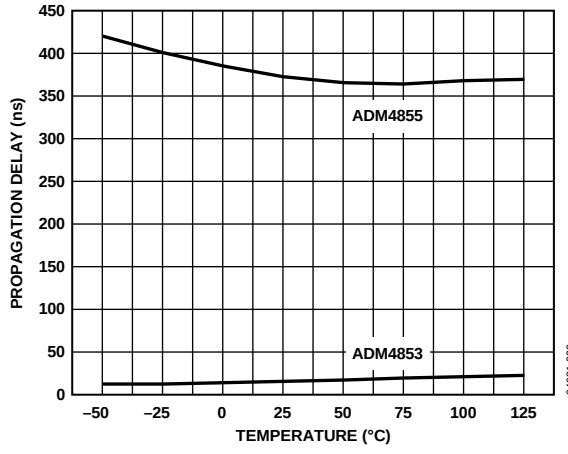


Figure 15. Driver Propagation Delay vs. Temperature (ADM4853/ADM4855)

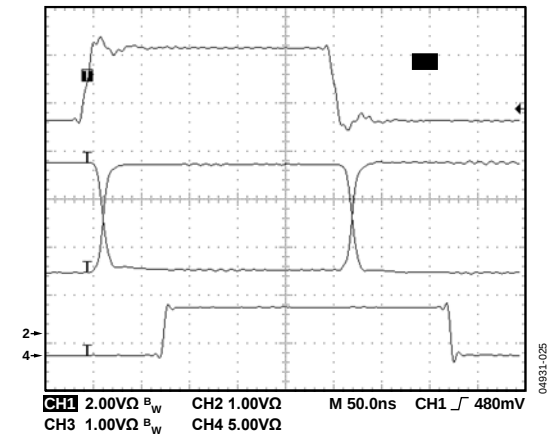


Figure 18. Driver/Receiver Propagation Delay (ADM4857, 4 Mbps)

TEST CIRCUITS

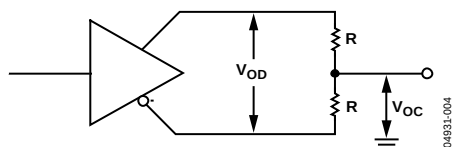


Figure 19. Driver Voltage Measurement

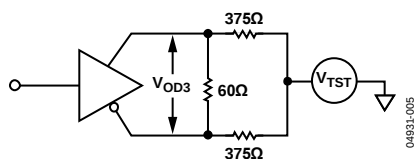


Figure 20. Driver Voltage Measurement over Common-Mode Voltage Range

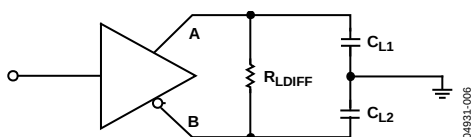


Figure 21. Driver Propagation Delay

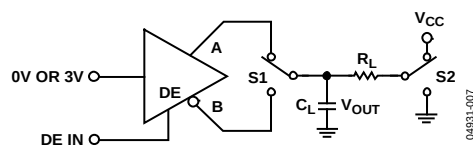


Figure 22. Driver Enable/Disable (ADM4850/ADM4852/ADM4853)

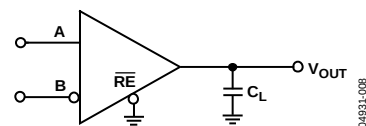


Figure 23. Receiver Propagation Delay

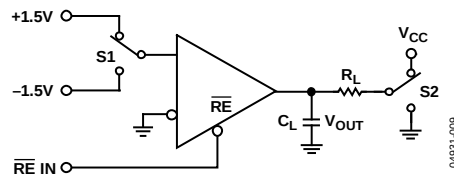


Figure 24. Receiver Enable/Disable (ADM4850/ADM4852/ADM4853)

SWITCHING CHARACTERISTICS

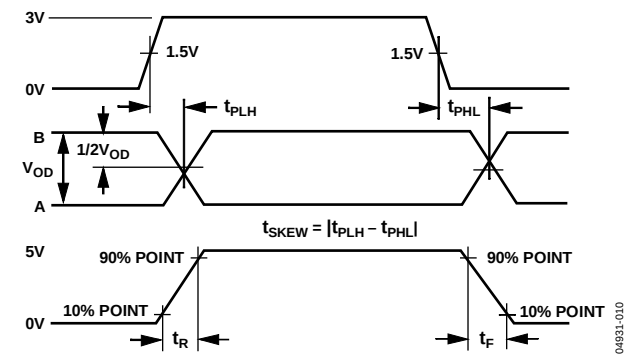


Figure 25. Driver Propagation Delay, Rise/Fall Timing

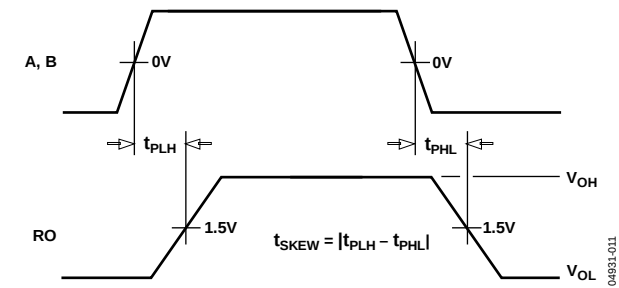


Figure 26. Receiver Propagation Delay

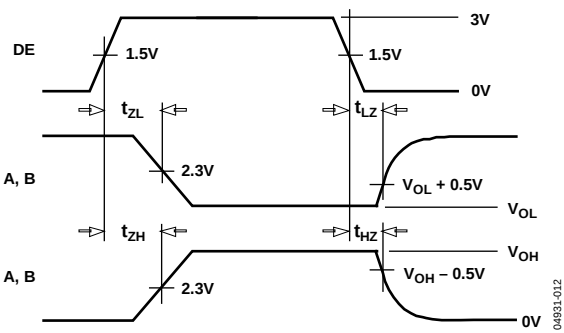


Figure 27. Driver Enable/Disable Timing

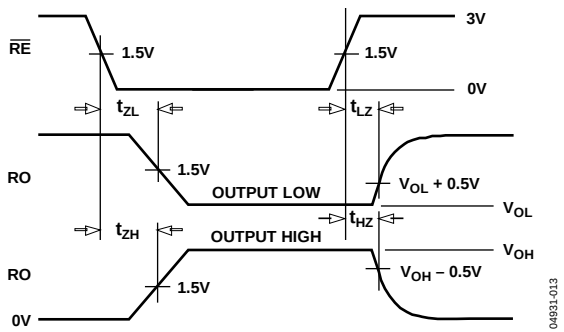


Figure 28. Receiver Enable/Disable Timing

THEORY OF OPERATION

The [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#) are high speed RS-485/RS-422 transceivers offering enhanced performance over industry-standard devices. All devices in the family contain one driver and one receiver but offer a choice of performance options. The devices feature true fail-safe operation, which guarantees a logic high receiver output when the receiver inputs are open circuit or short-circuit, or when they are connected to a terminated transmission line with all drivers disabled (see the Fail-Safe Operation section).

SLEW RATE CONTROL

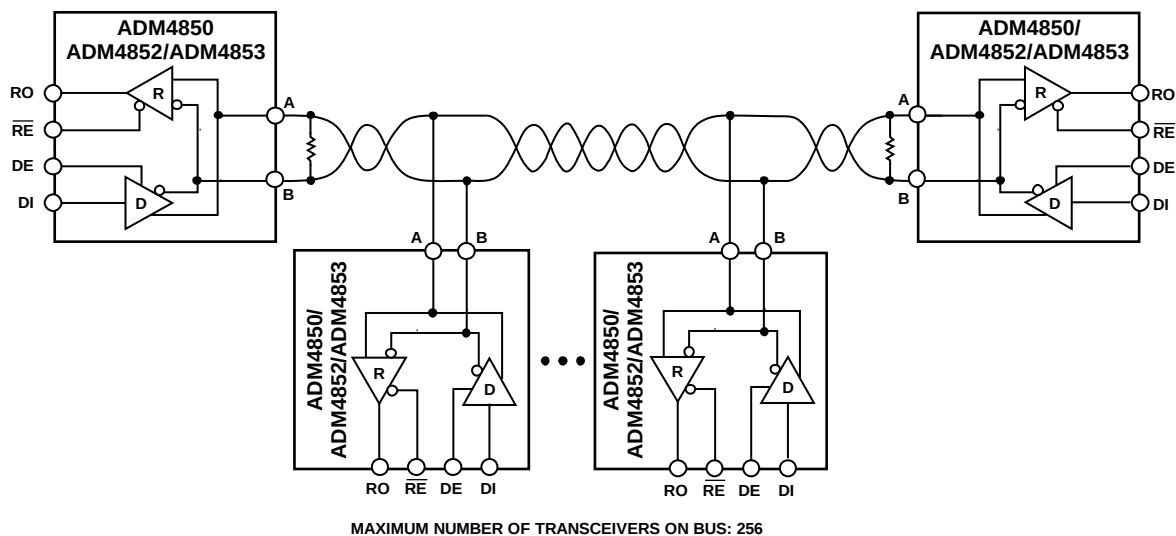
The [ADM4850](#) and [ADM4854](#) feature a controlled slew rate driver that minimizes EMI and reduces reflections caused by incorrectly terminated cables, allowing error free data transmission rates up to 115 kbps. The [ADM4851](#) and [ADM4855](#) offer a higher limit on driver output slew rate, allowing data transmission rates up to 500 kbps. The driver slew rates of the [ADM4852/ADM4856](#) and the [ADM4853/ADM4857](#) are not limited, offering data transmission rates up to 2.5 Mbps and 10 Mbps, respectively.

RECEIVER INPUT FILTERING

The receivers of all the devices incorporate input hysteresis. In addition, the receivers of the 115 kbps [ADM4850](#) and [ADM4854](#) and the 500 kbps [ADM4851](#) and [ADM4855](#) incorporate input filtering, which enhances noise immunity with differential signals that have very slow rise and fall times. However, it causes the propagation delay to increase by 20%.

HALF-DUPLEX/FULL DUPLEX OPERATION

Half-duplex operation implies that the transceiver can transmit and receive, but it can do only one of these at any given time. However, with full duplex operation, the transceiver can transmit and receive simultaneously. The [ADM4850/ADM4851/ADM4852/ADM4853](#) are half-duplex devices in which the driver and the receiver share differential bus terminals. The [ADM4854/ADM4855/ADM4856/ADM4857](#) are full duplex devices that have dedicated driver output and receiver input pins. Figure 29 and Figure 30 show typical half-duplex and full duplex topologies.



NOTES

1. THE ADM4851 IS A HALF-DUPLEX RS-485 TRANSCEIVER, BUT IT DOES NOT HAVE THE DRIVER ENABLE (DE) AND THE RECEIVER ENABLE ($\overline{RE}$) PINS.

Figure 29. Typical Half-Duplex RS-485 Network Topology

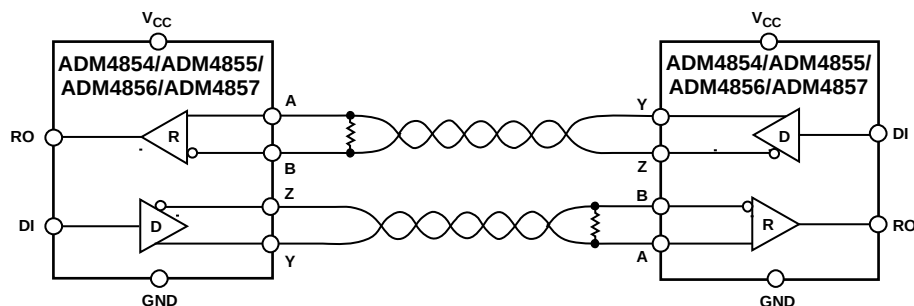


Figure 30. Typical Full Duplex Point-to-Point RS-485 Network Topology

HIGH RECEIVER INPUT IMPEDANCE

The input impedance of the [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#) receivers is 96 k Ω , which is eight times higher than the standard RS-485 unit load of 12 k Ω . This 96 k Ω impedance enables a standard driver to drive 32 unit loads or to be connected to 256 [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#) receivers. An RS-485 bus, driven by a single standard driver, can be connected to a combination of [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#) devices and standard unit load receivers, up to an equivalent of 32 standard unit loads.

THREE-STATE BUS CONNECTION

The half-duplex devices ([ADM4850/ADM4852/ADM4853](#)) have a driver enable pin (DE) that enables the driver outputs when taken high, or puts the driver outputs into a high impedance state when taken low. Similarly, the half-duplex devices have an active low receiver enable pin ($\overline{\text{RE}}$). Taking this pin low enables the receiver, whereas taking it high puts the receiver outputs into a high impedance state, which allows several driver outputs to be connected to an RS-485 bus. Note that only one driver must be enabled at a time, but that many receivers can be enabled.

SHUTDOWN MODE

The [ADM4850/ADM4852/ADM4853](#) have a low power shutdown mode, which is enabled by taking $\overline{\text{RE}}$ high and DE low. If shutdown mode is not used, the fact that DE is active high and $\overline{\text{RE}}$ is active low offers a convenient way of switching the device between transmit and receive by tying DE and $\overline{\text{RE}}$ together.

If DE is driven low and $\overline{\text{RE}}$ is driven high for less than 50 ns, the devices are guaranteed not to enter shutdown mode. If DE is driven low and $\overline{\text{RE}}$ is driven high for at least 3000 ns, the devices are guaranteed to enter shutdown mode.

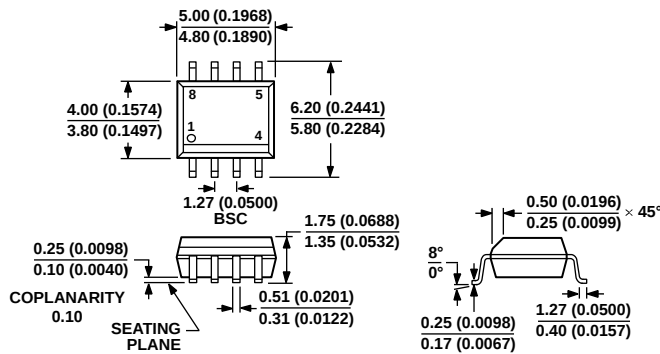
FAIL-SAFE OPERATION

The [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#) offer true fail-safe operation while remaining fully compliant with the ± 200 mV EIA/TIA-485 standard. A logic high receiver output generates when the receiver inputs are shorted together or open circuit, or when they are connected to a terminated transmission line with all drivers disabled. This logic high is done by setting the receiver threshold between -30 mV and -200 mV. If the differential receiver input voltage ($A - B$) is greater than or equal to -30 mV, RO is logic high. If ($A - B$) is less than or equal to -200 mV, RO is logic low. In the case of a terminated bus with all transmitters disabled, the differential input voltage of the receiver is pulled to 0 V by the internal circuitry of the [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#), which results in a logic high with 30 mV minimum noise margin.

CURRENT LIMIT AND THERMAL SHUTDOWN

The [ADM4850/ADM4851/ADM4852/ADM4853/ADM4854/ADM4855/ADM4856/ADM4857](#) incorporate two protection mechanisms to guard the drivers against short circuits, bus contention, or other fault conditions. The first is a current limiting output stage, which protects the driver against short circuits over the entire common-mode voltage range by limiting the output current to approximately 70 mA. Under extreme fault conditions where the current limit is not effective, a thermal shutdown circuit puts the driver outputs into a high impedance state if the die temperature exceeds 150°C, and does not turn them back on until the temperature falls to 130°C.

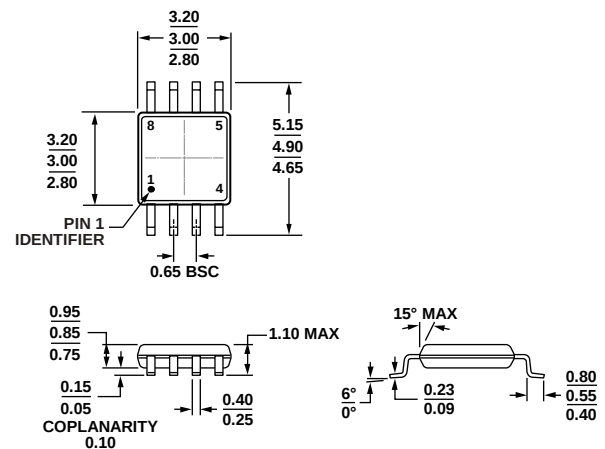
OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-012-AA
CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS
(IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 31. 8-Lead Standard Small Outline Package [SOIC_N]
Narrow Body
(R-8)

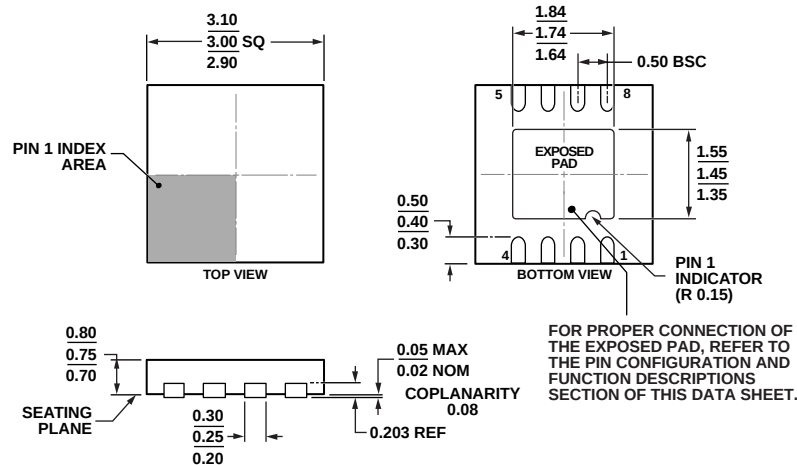
Dimensions shown in millimeters and (inches)



COMPLIANT TO JEDEC STANDARDS MO-187-AA

Figure 32. 8-Lead Mini Small Outline Package [MSOP]
(RM-8)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-229-WEED

Figure 33. 8-Lead Lead Frame Chip Scale Package [LFCSP]
3 mm x 3 mm Body and 0.75 mm Package Height
(CP-8-13)

Dimensions shown in millimeters

ORDERING GUIDE

Model ^{1, 2}	Temperature Range	Package Description	Package Option	Branding
ADM4850ACPZ-REEL7	−40°C to +85°C	8-Lead Lead Frame Chip Scale Package [LFCSP]	CP-8-13	M8Q
ADM4850ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4850ARZ-REEL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4850ARMZ	−40°C to +85°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	M8Q
ADM4850ARMZ-REEL7	−40°C to +85°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	M8Q
ADM4851ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4851ARZ-REEL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4852ACPZ-REEL7	−40°C to +85°C	8-Lead Lead Frame Chip Scale Package [LFCSP]	CP-8-13	M9M
ADM4852ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4852ARZ-REEL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4853ACPZ-REEL7	−40°C to +85°C	8-Lead Lead Frame Chip Scale Package [LFCSP]	CP-8-13	F0B
ADM4853ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4853ARZ-REEL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4853WARZ-RL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4854ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4855ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4856ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4856ARZ-REEL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4857ARZ	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM4857ARZ-REEL7	−40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	

¹ Z = RoHS Compliant Part.² W = Qualified for Automotive Applications.

AUTOMOTIVE PRODUCT

The [ADM4853WARZ-RL7](#) model is available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that this automotive model may have specifications that differ from the commercial models; therefore, designers should review the Specifications section of this data sheet carefully. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for this model.